Search Notes

1	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/634,055	YU, JEN-CHEN
П	Examiner	Art Unit
1	Michael A. Friedhofer	2832

SEARCHED				
Class	Subclass	Date	Examiner	
200	4,5r,6a,17r ,18,406, 332,335	8/23/2005	MAF	
345	157,161	8/23/2005	MAF	
463	36-38	8/23/2005	MAF	
341	20	8/23/2005	MAF	
273	148r	8/23/2005	MAF	
74	471	8/23/2005	MAF	
-				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
200	4,5r,6a	8/23/2005	MAF		
200	17r,18	8/23/2005	MAF		
200	406,332	8/23/2005	MAF		
200/335		8/23/2005	MAF		

		STRATEGY)		
	DATE	EXMR		
interference search: see search history	8/23/2005	MAF		
		-		